

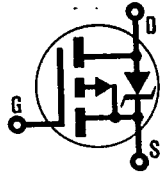
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REPETITIVE AVALANCHE AND dv/dt RATED

HEXFET® TRANSISTORS

- IRFR9020
- IRFR9022
- IRFU9020
- IRFU9022



P-CHANNEL

-50 Volt, 0.20 Ohm HEXFET

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dv/dt capability.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

Surface mount packages enhance circuit performance by reducing stray inductances and capacitance. The D-Pak (TO-252AA) surface mount package brings the advantages of HEXFETs to high volume applications where PC Board surface mounting is desirable. The surface mount option IRFR9020 is provided on 16mm tape. The straight lead option IRFU9020 of the device is called the I-Pak (TO-251AA).

They are well suited for applications where limited heat dissipation is required such as, computers and peripherals, telecommunications equipment, DC/DC converters, and a wide range of consumer products.

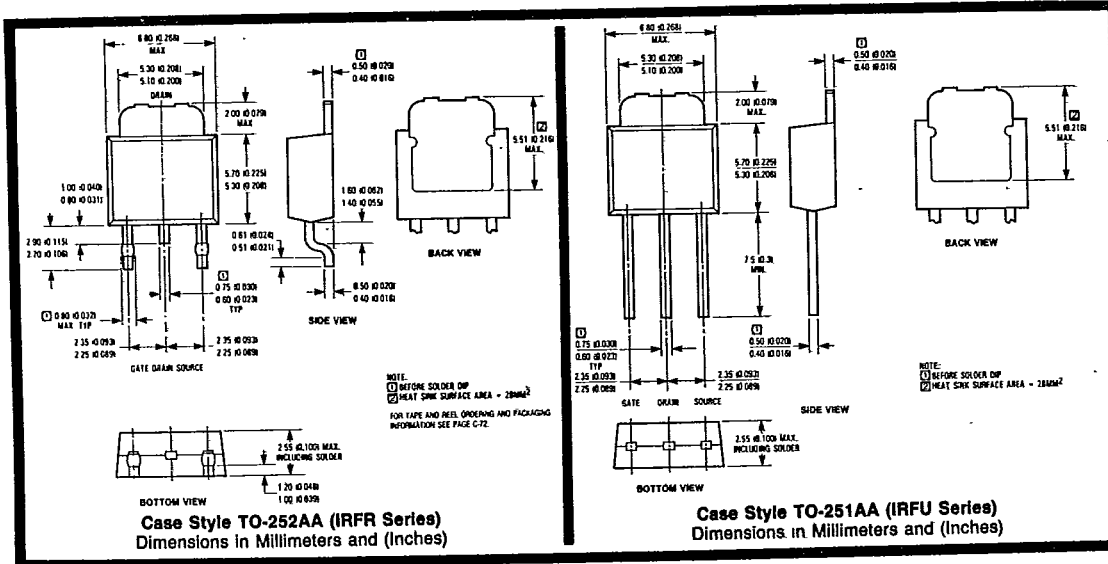
Product Summary

Part Number	BVDSS	R _{DS(on)}	I _D
IRFR9020	-50V	0.28Ω	-9.9A
IRFR9022	-50V	0.33Ω	-9.0A
IRFU9020	-50V	0.28Ω	-9.9A
IRFU9022	-50V	0.33Ω	-9.0A

D-PAK

FEATURES:

- Surface Mountable (Order As IRFR9020)
- Straight Lead Option (Order As IRFU9020)
- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling



IRFR9020, IRFR9022, IRFU9020, IRFU9022 Devices

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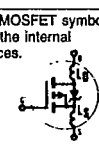
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Absolute Maximum Ratings


Parameter	IRFR9020, IRFU9020	IRFR9022, IRFU9022	Units
$I_D @ T_C = 25^\circ\text{C}$ Continuous Drain Current	-9.9	-9.0	A
$I_D @ T_C = 100^\circ\text{C}$ Continuous Drain Current	-6.3	-5.7	A
I_{DM} Pulsed Drain Current (1)	-40	-36	A
$P_D @ T_C = 25^\circ\text{C}$ Max. Power Dissipation	42		W
Linear Derating Factor	0.33		W/K (5)
V_{GS} Gate-to-Source Voltage	± 20		V
E_{AS} Single Pulse Avalanche Energy (2)	440 (See Fig. 14)		mJ
I_{AR} Avalanche Current (Repetitive or Non-Repetitive) (1)	-9.9 (See E_{AR})		A
E_{AR} Repetitive Avalanche Energy (1)	4.2 (See I_{AR})		mJ
dv/dt Peak Diode recovery dv/dt (3)	5.8 (See Fig. 17)		V/ns
T_J Operating Junction Temperature Range	-55 to 150		$^\circ\text{C}$
T_{STG} Storage Temperature Range	-55 to 150		$^\circ\text{C}$
Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)		$^\circ\text{C}$

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (Unless Otherwise Specified)

Parameter	Type	Min.	Typ.	Max.	Units	Test Conditions
BV_{DSS} Drain-to-Source Breakdown Voltage	All	-50			V	$V_{GS} = 0V, I_D = -250\mu\text{A}$
$R_{DS(on)}$ Static Drain-to-Source On-State Resistance (4)	IRFR9020 IRFU9020	—	0.20	0.28	Ω	$V_{GS} = -10V, I_D = 5.7A$
	IRFR9022 IRFU9022	—	0.28	0.33		
$I_{D(on)}$ On-State Drain Current (4)	IRFR9020 IRFU9020	-9.9	—	—	A	$V_{DS} > I_{D(on)} \times R_{DS(on)}$ Max. $V_{GS} = -10V$
	IRFR9022 IRFU9022	-9.0	—	—		
$V_{GS(th)}$ Gate Threshold Voltage	ALL	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
g_{fs} Forward Transconductance (4)	ALL	2.3	3.5	—	S(V)	$V_{DS} \leq -50V, I_{DS} = -5.7A$
I_{DSS} Zero Gate Voltage Drain Current	ALL	—	—	250	μA	$V_{DS} = \text{Max. Rating}, V_{GS} = 0V$
		—	—	1000		
I_{GSS} Gate-to-Source Leakage Forward	ALL	—	—	-500	nA	$V_{GS} = -20V$
I_{GSS} Gate-to-Source Leakage Reverse	ALL	—	—	500	nA	$V_{GS} = 20V$
Q_g Total Gate Charge	ALL	—	9.4	14	nC	$V_{GS} = -10V, I_D = -9.7A$
Q_{gs} Gate-to-Source Charge	ALL	—	4.3	6.5	nC	$V_{DS} = 0.8 \times \text{Max. Rating}$
Q_{gd} Gate-to-Drain ("Miller") Charge	ALL	—	4.3	6.5	nC	See Fig. 16 (Independent of operating temperature)
$t_{d(on)}$ Turn-On Delay Time	ALL	—	8.2	12	ns	$V_{DD} = -25V, I_D = -9.7A, R_G = 18\Omega$ $R_D = 2.4\Omega$ See Fig. 15
t_r Rise Time	ALL	—	57	88	ns	
$t_{d(off)}$ Turn-Off Delay Time	ALL	—	12	18	ns	
t_f Fall Time	ALL	—	25	38	ns	(Independent of operating temperature)
L_D Internal Drain Inductance	ALL	—	4.5	—	nH	Measured from the drain lead, 6mm (0.25 in.) from package to center of die.
L_S Internal Source Inductance	ALL	—	7.5	—	nH	Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.
C_{iss} Input Capacitance	ALL	—	490	—	pF	$V_{GS} = 0V, V_{DS} = -25V$ $f = 1.0 \text{ MHz}$ See Fig. 10
C_{oss} Output Capacitance	ALL	—	320	—	pF	
C_{rss} Reverse Transfer Capacitance	ALL	—	70	—	pF	



Source-Drain Diode Ratings and Characteristics

Parameter	Type	Min.	Typ.	Max.	Units	Test Conditions
I_S Continuous Source Current (Body Diode)	ALL	—	—	-9.9	A	Modified MOSFET symbol showing the integral Reverse p-n junction rectifier. 
I_{SM} Pulsed Source Current (Body Diode) ①	ALL	—	—	-40	A	
V_{SD} Diode Forward Voltage ④	ALL	—	—	-6.3	V	$T_J = 25^\circ\text{C}, I_S = -9.9\text{A}, V_{GS} = 0\text{V}$
t_{rr} Reverse Recovery Time	ALL	56	110	280	ns	$T_J = 25^\circ\text{C}, I_F = -9.7\text{A}, di/dt = 100\text{ A}/\mu\text{s}$
Q_{RR} Reverse Recovery Charge	ALL	0.17	0.34	0.85	μC	
t_{on} Forward Turn-On Time	ALL	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

Thermal Resistance

R_{thJC} Junction-to-Case	ALL	—	—	3.0	K/W ⑤	
R_{thCS} Case-to-Sink	ALL	—	1.7	—	K/W ⑤	Typical solder mount ⑥
R_{thJA} Junction-to-Ambient	ALL	—	—	110	K/W ⑤	Typical socket mount



- ① Repetitive Rating; Pulse width limited by maximum junction temperature (see figure 5)
- ② @ $V_{DD} = -25\text{V}$, Starting $T_J = 25^\circ\text{C}$, $L = 5.1\text{ mH}$, $R_G = 25\Omega$, Peak $I_L = -9.9\text{A}$
- ③ $I_{SD} \leq -9.9\text{A}$, $di/dt \leq -120\text{A}/\mu\text{s}$, $V_{DD} \leq 40\text{V}$, $T_J \leq 150^\circ\text{C}$, Suggested $R_G = 18\Omega$
- ④ Pulse width $\leq 300\ \mu\text{s}$; Duty Cycle $\leq 2\%$
- ⑤ $K/W = \text{ }^\circ\text{C}/\text{W}$
 $W/K = \text{W}/\text{ }^\circ\text{C}$
- ⑥ Mounting pad must cover heatsink surface area. See case style drawing on front page.

The information shown on the following graphs applies also to the IRFU devices.

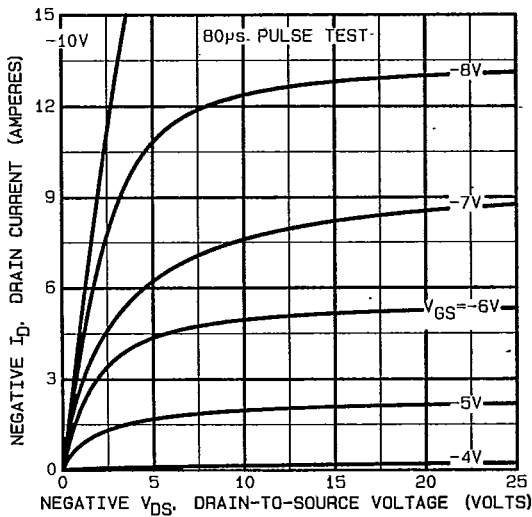


Fig. 1 — Typical Output Characteristics

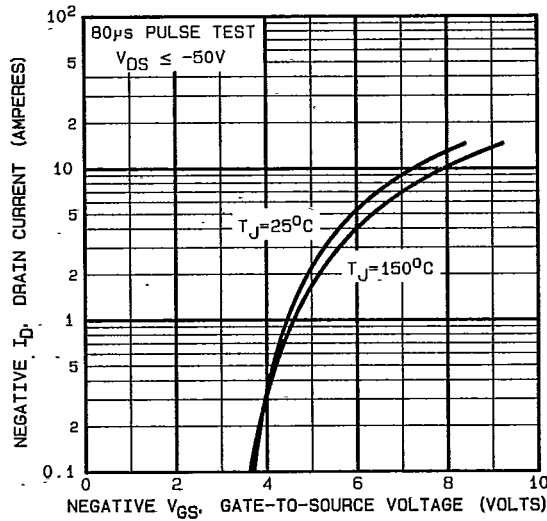


Fig. 2 — Typical Transfer Characteristics

IRFR9020, IRFR9022, IRFU9020, IRFU9022 Devices

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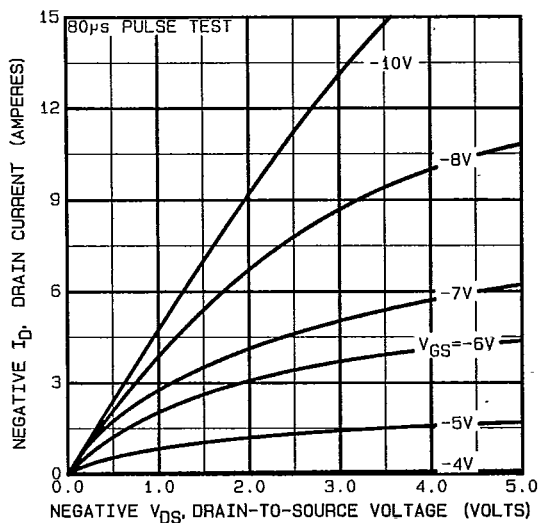


Fig. 3 — Typical Saturation Characteristics

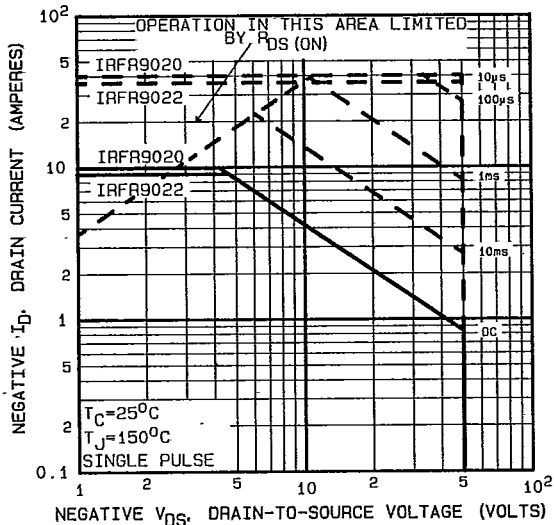


Fig. 4 — Maximum Safe Operating Area

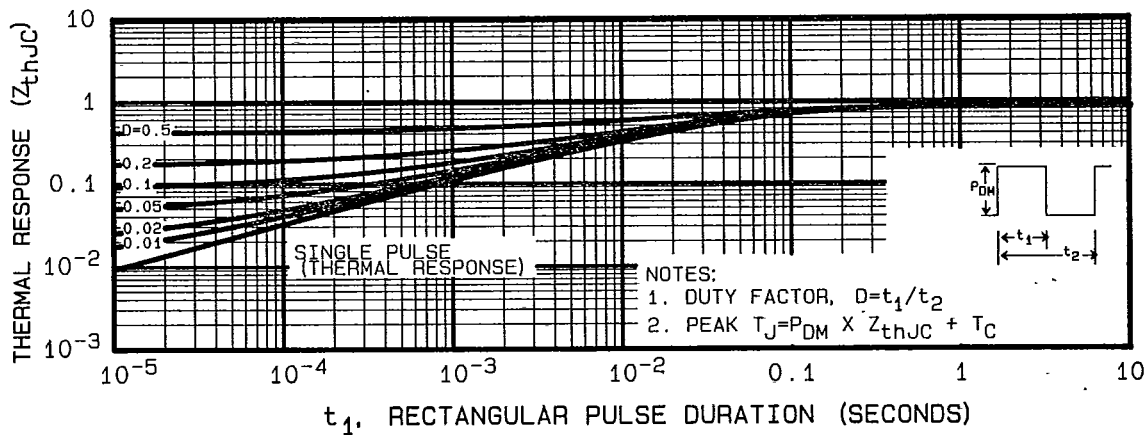


Fig. 5 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

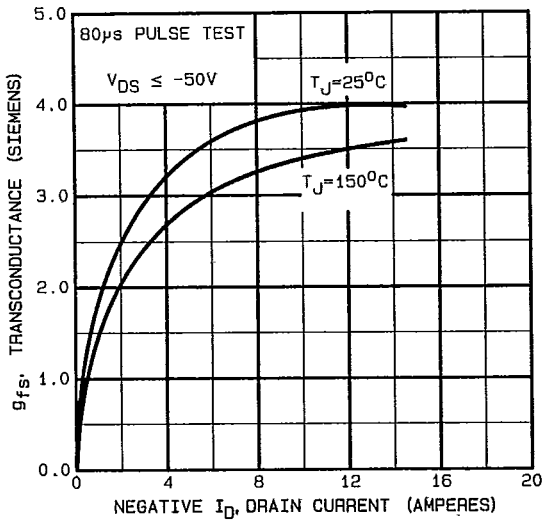


Fig. 6 — Typical Transconductance Vs. Drain Current

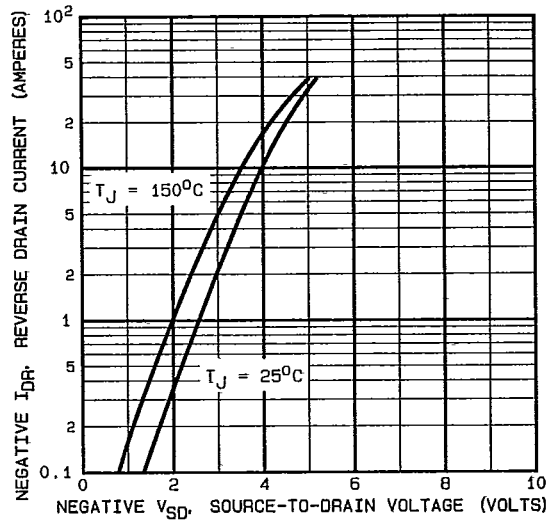


Fig. 7 — Typical Source-Drain Diode Forward Voltage

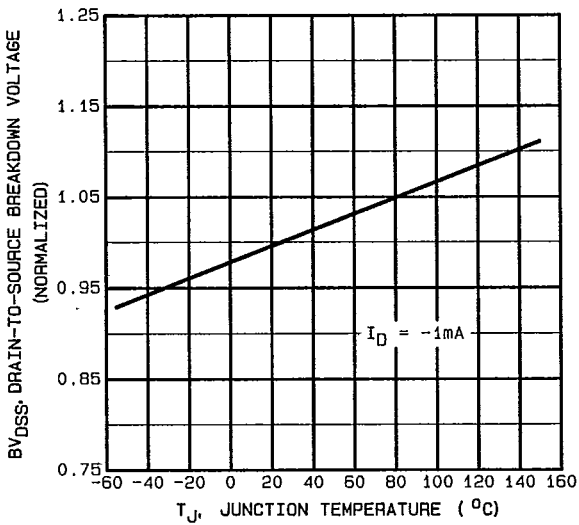


Fig. 8 — Breakdown Voltage Vs. Temperature

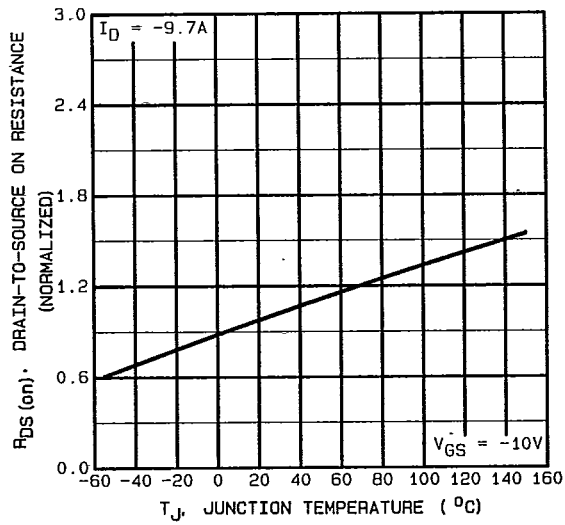


Fig. 9 — Normalized On-Resistance Vs. Temperature

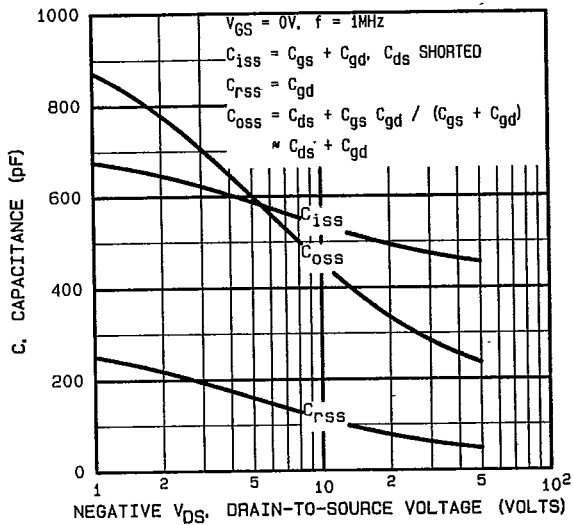


Fig. 10 — Typical Capacitance Vs. Drain-to-Source Voltage

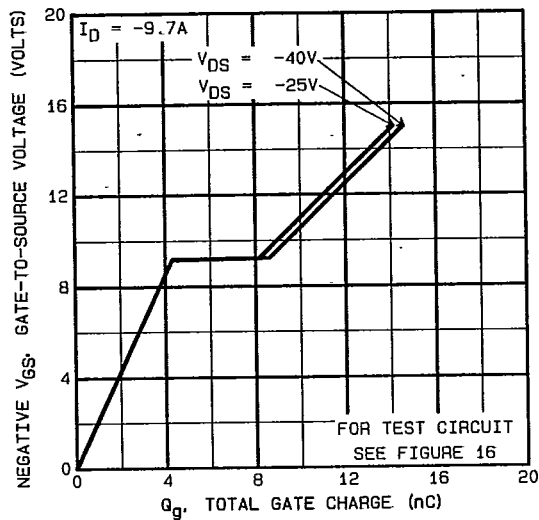


Fig. 11 — Typical Gate Charge Vs. Gate-to-Source Voltage

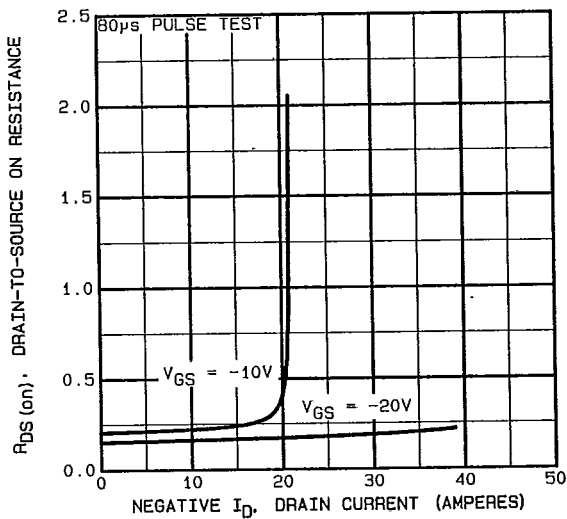


Fig. 12 — Typical On-Resistance Vs. Drain Current

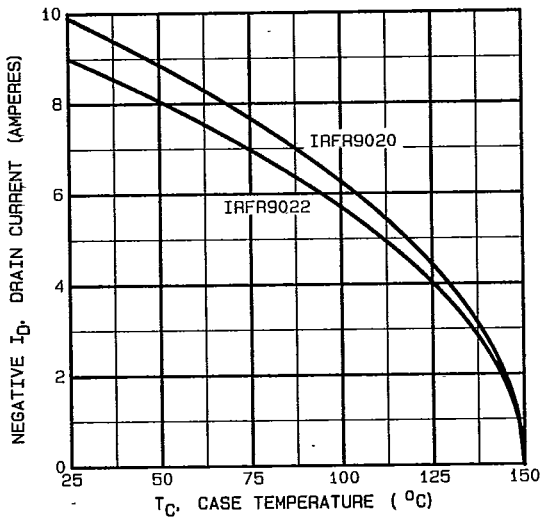


Fig. 13 — Maximum Drain Current Vs. Case Temperature

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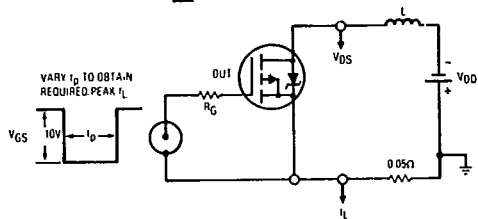


Fig. 14a — Unclamped Inductive Test Circuit

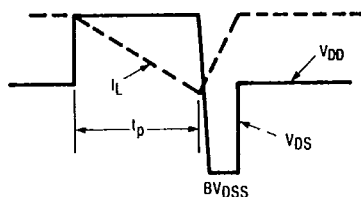


Fig. 14b — Unclamped Inductive Waveforms

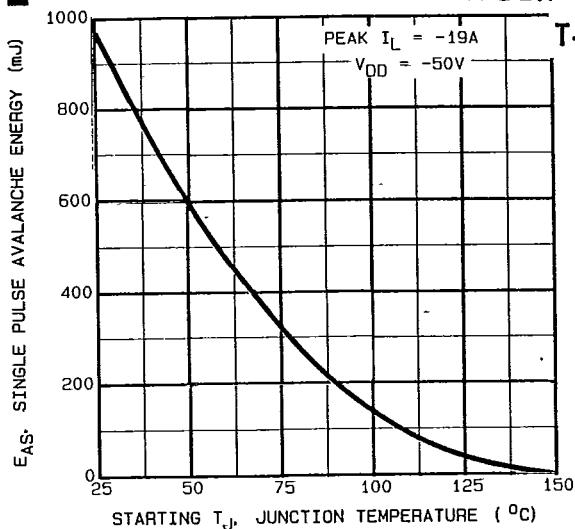


Fig. 14c — Maximum Avalanche Vs. Starting Junction Temperature

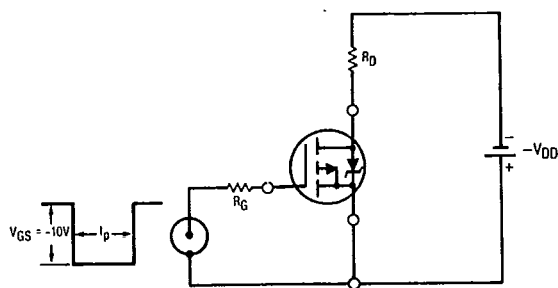


Fig. 15a — Switching Time Test Circuit

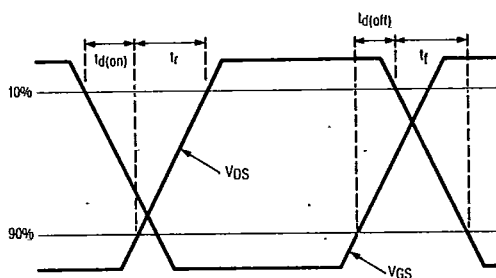


Fig. 15b — Switching Time Waveforms

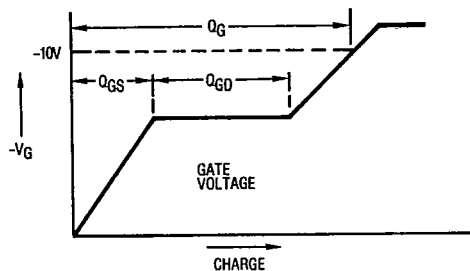


Fig. 16a — Basic Gate Charge Waveform

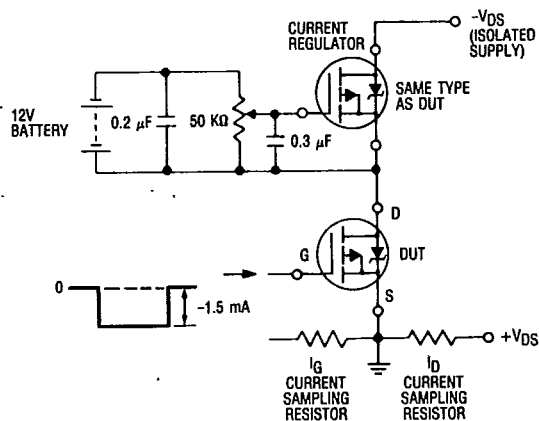


Fig. 16b — Gate Charge Test Circuit

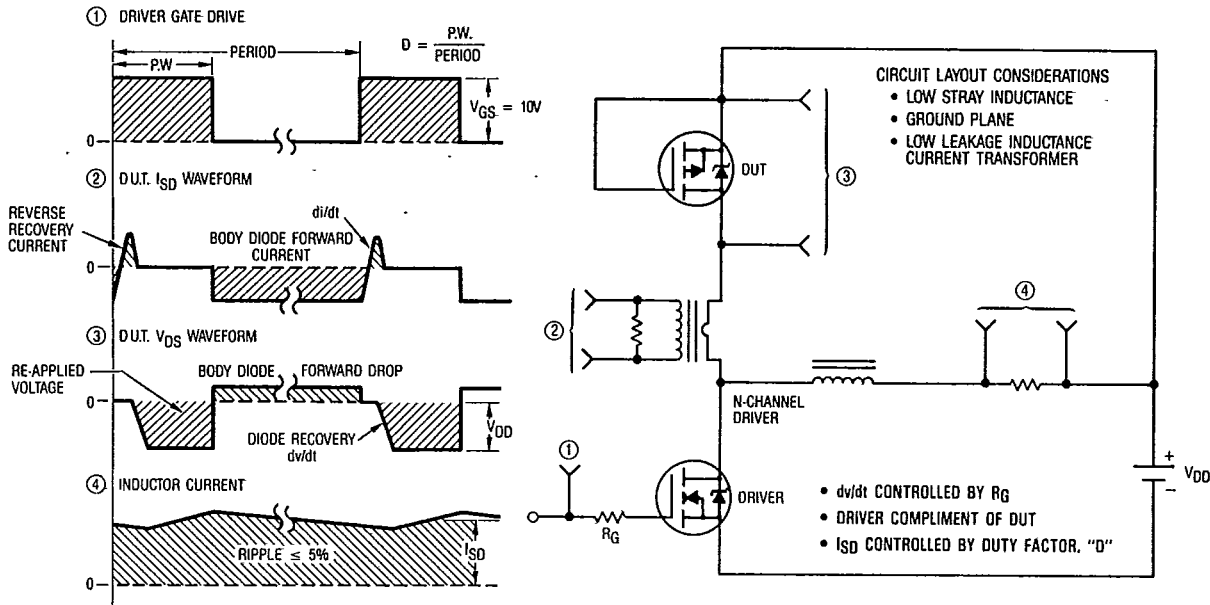


Fig. 17 — Peak Diode Recovery dv/dt Test Circuit

ORDERING INFORMATION

IRFR Series — Tape and reel
 when ordering, add TR after the part number
 and the quantity
 (order in multiples of 3,000 pieces).

Example: IRFR9020TR — 15,000 pieces.

PACKAGING

